

Applications

- Small Cell BTS
- 3G/4G Wireless infrastructure
- Linearized Transmitter
- W-CDMA/ LTE/ CDMA
- Heterogeneous Networks

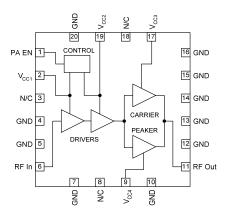


20 Pin 20x20 mm Plastic Package

Product Features

- 2110-2170 MHz
- 2.5 W RMS Output Power
- Integrated Doherty Final Stage
- Three Stage Power Added Efficiency: 35 %
- 50 Ω Input / Output
 Power Gain: 34 dB
 Peak Power: 18 W
- Package Dimensions: 20 x 20 x 1.5 mm
- 100 % DC and RF tested

Functional Block Diagram



General Description

The TGA2450-SM is a fully integrated surface mount 3-stage Power Amplifier Module ideally suited for 3G and 4G small cell base station applications with 1 W RMS at the antenna. The module is 50 Ω input and output and requires minimal external components. The module is also compact and offers a much smaller footprint than traditional discrete component solutions.

The TGA2450-SM incorporates a Doherty final stage delivering high power added efficiency of 35 % for the entire module at 2.5 W average power.

The TGA2450-SM supports multi-mode and multi-carrier signals. The module includes InGaP/GaAs HBT device technology to provide a combination of high efficiency and DPD friendliness.

Lead-free and RoHS compliant.

Evaluation Board is available upon request.

Pin Configuration

Pin No.	Label
1	PA EN
2	V _{CC1}
3, 8, 18	N/C
4, 5, 7, 10, 12-16, 20	GND
6	RF IN
9	V _{CC4}
11	RF OUT
17	V _{CC3}
19	V _{CC2}
Backside Paddle	RF/DC GND
17 19	V _{CC3}

Ordering Information

Part No.	Description
TGA2450-SM	Small Cell PAM
TGA2450-SM-PCB	2110-2170 MHz Eval Board



Absolute Maximum Ratings

Parameter	Rating	
Collector Voltage (V _{CC1})	6 V	
Collector Voltage (V _{CC2} , V _{CC3} , V _{CC4})	19 V	
RF Input Power Over Drive above	8 dB	
P_{IN} at 34 dBm P_{OUT} , 50 Ω, T = 25°C	0 00	
VSWR at P _{OUT} with 1 dB PAR compression with WCDMA signal	5:1	
Storage Temperature	-65°C to 150°C	
Case Temperature (Backside Pads)	120°C	

Operation of this device outside the parameter ranges given above may cause permanent damage.

Recommended Operating Conditions

Parameter	Min	Тур	Max	Units
Operating Temperature	-40	+25	+90	°C
V _{CC1}		5		V
V_{CC2} , V_{CC3} , V_{CC4}		18		V
PA Enable On	1.15	1.2-5.5	6	V
PA Enable Off		0	0.6	V
I _{CQ1} (at V _{CC1})		60		mA
I _{CQ2} (at V _{CC2})		25		mA
I _{CQ3} (at V _{CC3})		90		mA
Tj for > 10 ⁶ hours MTTF			200	°C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications at T_{CASE} = 25°C

Test conditions unless otherwise noted: $V_{CC1} = 5 \text{ V}$, $V_{CC2} = 18 \text{ V}$, $V_{CC3} = 18 \text{ V}$, $V_{CC4} = 18 \text{ V}$, $I_{CQ1} = 60 \text{ mA}$, $I_{CQ2} = 25 \text{ mA}$, $I_{CQ3} = 90 \text{ mA}$, I_{CQ3}

Parameter	Conditions	Min	Тур	Max	Units
RF Frequency Range		2110		2170	MHz
I _{CQ1}	V _{CC1} = 5 V	35	60	80	mA
I _{CQ2} +I _{CQ3}	$V_{CC2} = V_{CC3} = 18 \text{ V}$	90	115	140	mA
Power Gain	P _{OUT} = 34 dBm average	32.2	34.4		
Gain flatness across any 40 MHz in-band	P _{OUT} = 34 dBm average		1	2	dB
Average Output Power			+34		dBm
P3dB	Pulsed, 10 µsec width, 1 msec period	+41.9	+42.6		dBm
Power Added Efficiency	P _{OUT} = 34 dBm average	33.2	35.4		%
ACLR DPD corrected	5-20 MHz SBW UMTS/LTE		-55		dBc
Input/Output Impedance			50		ohm
Input Return Loss	P _{OUT} = 34 dBm average		13	11	dB
Group delay				5	nS
Group delay ripple				750	pS
Noise Figure				3	dB



Electrical Specifications at T_{CASE} = −40°C to +90°C

Test conditions unless otherwise noted: V_{CC1} = 5 V, V_{CC2} = 18 V, V_{CC3} = 18 V, V_{CC4} = 18 V, I_{CQ1} = 60 mA, I_{CQ2} = 25 mA, I_{CQ3} = 90 mA, P_{OUT} = 34 dBm, System impedance = 50 Ω

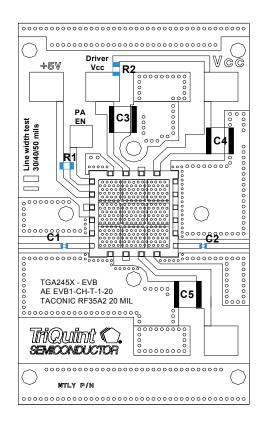
Parameter	Conditions	Min	Тур	Max	Units
Power Gain	P _{OUT} = 34 dBm average	29.9		38.6	dB
I _{CQ1}	V _{CC1} = 5 V	29	60	86	mA
I _{CQ2} +I _{CQ3}	V _{CC2} = V _{CC3} = 18 V	84	115	146	mA
I _{CC1}	V _{CC1} = 5 V, Pout = 34 dBm average			95	mA
Gain flatness across any 40 MHz in-band	P _{OUT} = 34 dBm average		1	2	dB
P3dB	Pulsed, 10 µsec width, 1 msec period	41			dBm
Power Added Efficiency	P _{OUT} = 34 dBm average	30			%
Input Return Loss	P _{OUT} = 34 dBm average		13	11	dB
Second Harmonic	P_{OUT} = 34 dBm at f_0 with WCDMA, 3.84 MHz IBW			-43	dBc
Third Harmonic	P_{OUT} = 34 dBm at f_0 with WCDMA, 3.84 MHz IBW			-37	dBc
Group delay				5	nS
Group delay ripple				750	pS
S12 - S21		15			dB
Thermal Resistance, θ _{jc} ⁽¹⁾	(junction to case), T _{CASE} = 90°C		14.8		°C/W

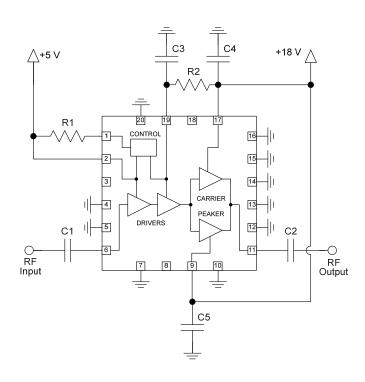
Notes:

^{1.} Measured carrier amplifier junction to package backside.



PC Board Layout and Evaluation Board Diagram





Bill of Material - TGA2450-SM-PCB Evaluation Board

Reference Des.	Value	Description	Manuf.	Part Number
Connector	n/a	N-type Connector	Huber+Suhner	23_N-50-0-16/133_NE
R2	0 Ω	Jumper		1206 0 ohm resistor
R1	10 kΩ	Resistor		1206 10K resistor
C1, C2	33 pF	Capacitor	ATC	0603 600S 33pF capacitor
C3, C4, C5 ⁽¹⁾	10 μF	Capacitor	TDK	2220 X7R 10uF 50V
PCB	n/a	Taconic RF35 A2 20 mils		AE EVB1 CH-T-1-20

Notes:

1. C3, C4, C5 can be replaced by 10 µF 50 V Electrolytic capacitor if it is needed.

Bias-up Procedure

- 1. Attach input and output loads onto evaluation board.
- 2. Turn on 18 V power supply V_{CC2}, V_{CC3}, V_{CC4}.
- 3. Turn on 5 V power supply V_{CC1}.
- 4. Apply RF signal.
- 5. Turn on RF power.

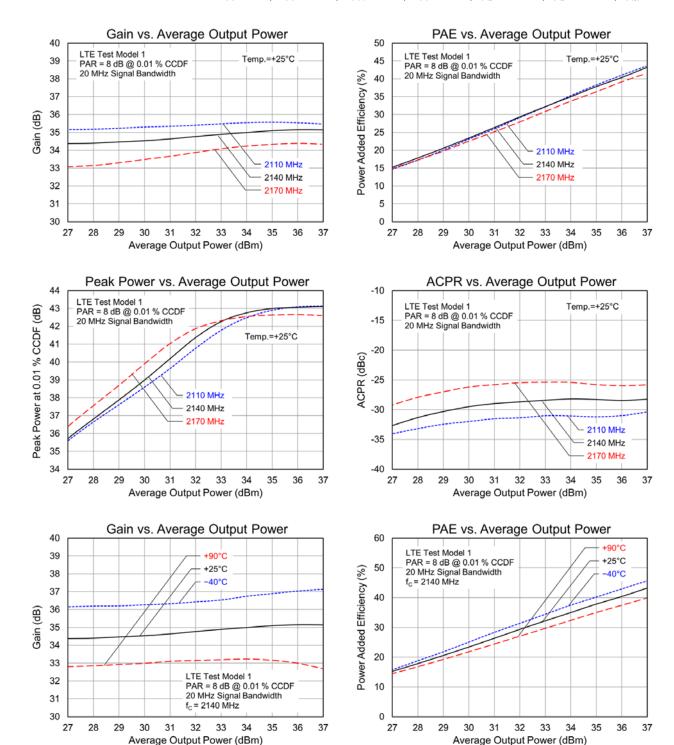
Bias-down Procedure

- 1. Turn off RF power.
- 2. Turn off PA EN.
- 3. Turn off 5 V power supply V_{CC1}.
- 4. Turn off 18 V power supply V_{CC2}, V_{CC3}, V_{CC4}.



Performance Plots

Test conditions unless otherwise noted: V_{CC1} = 5 V, V_{CC2} = 18 V, V_{CC3} = 18 V, V_{CC4} = 18 V, I_{CQ1} = 60 mA, I_{CQ2} = 25 mA, I_{CQ3} = 90 mA

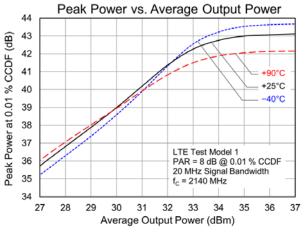


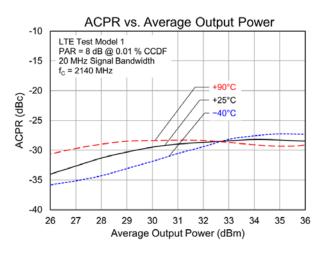


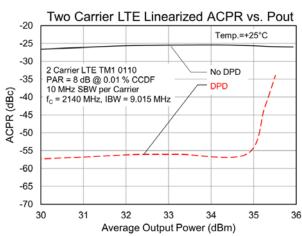
Performance Plots

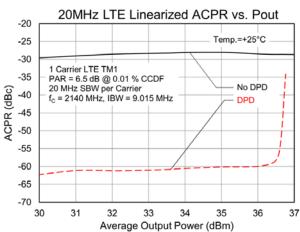
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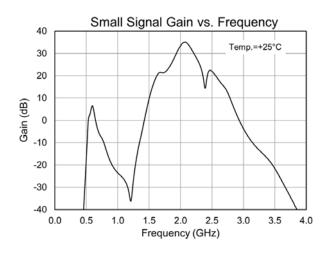
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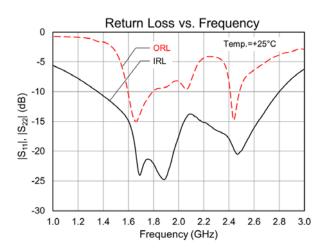






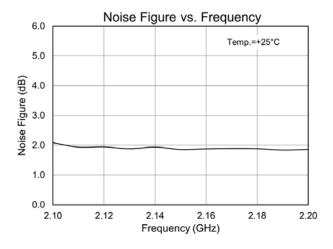




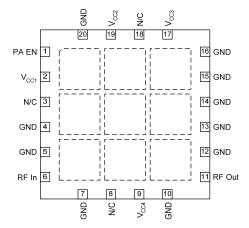


Performance Plots

Test conditions unless otherwise noted: $V_{CC1} = 5 \text{ V}$, $V_{CC2} = 18 \text{ V}$, $V_{CC3} = 18 \text{ V}$, $V_{CC4} = 18 \text{ V}$, $I_{CQ1} = 60 \text{ mA}$, $I_{CQ2} = 25 \text{ mA}$, $I_{CQ3} = 90 \text{ mA}$



Pin Configuration and Description

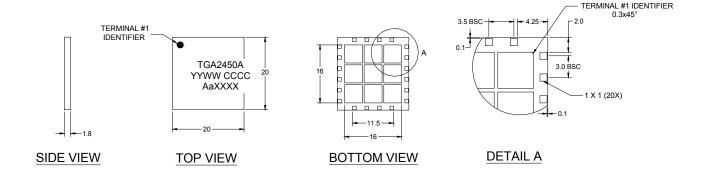


Pin No.	Label	Description
1	PA EN	Control Voltage. See Recommended Operating Conditions on page 2.
2	V _{CC1}	Bias Voltage for pre-driver stage.
3, 8, 18	N/C	No electrical connection. Provide grounded land pads for PCB mounting integrity.
4, 5, 7, 10, 12-16, 20	GND	Internal grounding; must be grounded on PCB.
6	RF In	RF Output matched to 50 Ω.
9	V _{CC4}	Bias Voltage for output stage.
11	RF Out	RF Output matched to 50 Ω.
17	V _{CC3}	Bias Voltage for output stage.
19	V _{CC2}	Bias Voltage for driver stage.



Package Marking and Dimensions

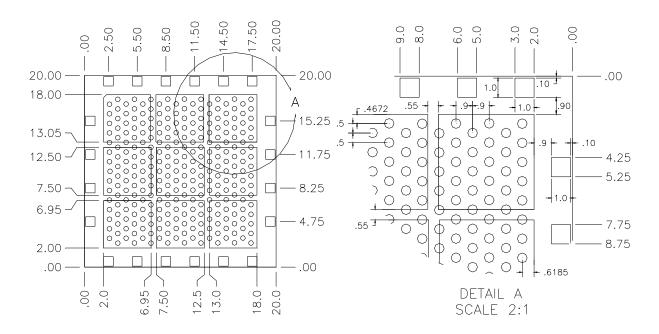
Marking: Part number – TGA2450A Year/week/country code – YYWW CCCC Lot code – AaXXXX



Notes:

1. All dimensions are in millimeters. Angles are in degrees.

PCB Mounting Pattern



Notes:

- 1. All dimensions are in millimeters. Angles are in degrees.
- 2. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances. Since surface mount processes vary from company to company, careful process development is recommended.
- 3. Ground / thermal vias are critical for the proper performance of this device. Vias should use a 0.508 mm diameter drill and have a final plated thru diameter of 0.35 mm.

Datasheet: Rev B 08-14-13 © 2013 TriQuint

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Disclaimer: Subject to change without notice www.triquint.com





Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: Class 1C Value: Passes ≥ 1000 V

Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

MSL Rating

MSL Rating: Level 3

Test: 260°C convection reflow

Standard: JEDEC Standard IPC/JEDEC J-STD-020

Solderability

Compatible with both lead-free (260°C maximum reflow temperature) and tin/lead (245°C maximum reflow temperature) soldering processes.

Contact plating: NiPdAu

RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- · Antimony Free
- TBBP-A (C₁₅H₁₂Br₄0₂) Free
- PFOS FreeSVHC Free

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